

<b>Notice of References Cited</b>			Application/Control No.	Applicant(s)/Patent Under Reexamination SEN ET AL.	
			Examiner Tae H. Yoon	Art Unit 1714	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-4,172,064	10-1979	Keeler, Joseph M.	524/762
*	B	US-5,242,888	09-1993	Atherton et al.	503/227
*	C	US-6,872,278	03-2005	Lehman et al.	156/327
*	D	US-2005/0009954 A1	01-2005	Gebhard et al.	523/210
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

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